

<b>Search Notes</b> 	<b>Application/Control No.</b>  09/617,868	<b>Applicant(s)/Patent under Reexamination</b>  SHAW, THOMAS J.
	<b>Examiner</b>  Mark K. Han	<b>Art Unit</b>  3767

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner